Elektronische Bauelemente

SSD15N10-C

15A, 100V, $R_{DS(ON)}$ 110mΩ
N-Ch Enhancement Mode Power MOSFET

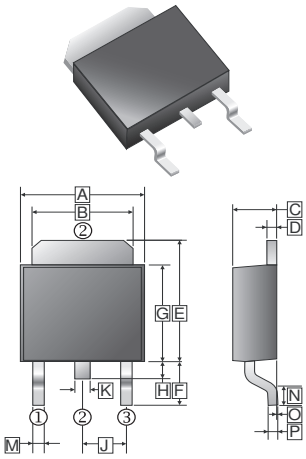
RoHS Compliant Product
A suffix of "-C" specifies halogen free

DESCRIPTION

The SSD15N10-C is the highest performance trench N-ch MOSFETs with extreme high cell density, which provide excellent R_{DSON} and gate charge for most of the synchronous buck converter applications.

The SSD15N10-C meet the RoHS and Green Product requirement with full function reliability approved.

TO-252(D-Pack)

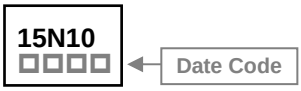


REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	6.3	6.9	J	2.3 REF.	
B	4.95	5.53	K	0.89 REF.	
C	2.1	2.5	M	0.45	1.14
D	0.4	0.9	N	1.55 Typ.	
E	6	7.7	O	0	0.15
F	2.90 REF		P	0.58 REF.	
G	5.4	6.4			
H	0.6	1.2			

FEATURES

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Green Device Available

MARKING

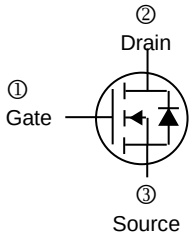


PACKAGE INFORMATION

Package	MPQ	Leader Size
TO-252	2.5K	13 inch

ORDER INFORMATION

Part Number	Type
SSD15N10-C	Lead (Pb)-free and Halogen-free



ABSOLUTE MAXIMUM RATINGS

Parameter		Symbol	Ratings	Unit
Drain-Source Voltage		V_{DS}	100	V
Gate-Source Voltage		V_{GS}	±20	V
Continuous Drain Current, V_{GS}@10V [1]	T_C=25℃	I_D	15	A
	T_C=100℃		10.5	A
Pulsed Drain Current [3]		I_{DM}	30	A
Power Dissipation	T_C=25℃	P_D	44.6	W
	T_A=25℃		2	W
Operating Junction and Storage Temperature Range		T_J, T_{STG}	-55 ~ 150	℃
Thermal Resistance Ratings				
Maximum Thermal Resistance Junction-Ambient [1]		$R_{\theta JA}$	62.5	℃ / W
Maximum Thermal Resistance Junction-Ambient [2]			110	
Maximum Thermal Resistance Junction-Case		$R_{\theta JC}$	2.8	

ELECTRICAL CHARACTERISTICS (T_J=25°C unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test conditions
Drain-Source Breakdown Voltage	BV_{DSS}	100	-	-	V	V_{GS}=0, I_D=250μA
Gate Threshold Voltage	$V_{GS(th)}$	1.0	-	2.5	V	V_{DS}=V_{GS}, I_D=250μA
Gate-Source Leakage Current	I_{GSS}	-	-	±100	nA	V_{GS}= ±20V
Drain-Source Leakage Current	I_{DSS}	-	-	1	μA	V_{DS}=80V, V_{GS}=0, T_J=25℃
		-	-	5		V_{DS}=80V, V_{GS}=0, T_J=55℃
Static Drain-Source On-Resistance [4]	$R_{DS(ON)}$	-	-	110	mΩ	V_{GS}=10V, I_D=8A
		-	-	120		V_{GS}=4.5V, I_D=6A
Total Gate Charge [2]	Q_g	-	26.2	-	nC	I_D=10A V_{DS}=80V V_{GS}=10V
Gate-Source Charge	Q_{gs}	-	4.6	-		
Gate-Drain (“Miller”) Change	Q_{gd}	-	5.1	-		
Turn-on Delay Time [2]	$T_{d(on)}$	-	4.2	-	nS	V_{DS}=50V I_D= 10A V_{GS}=10V R_G=3.3Ω
Rise Time	T_r	-	8.2	-		
Turn-off Delay Time	$T_{d(off)}$	-	35.6	-		
Fall Time	T_f	-	9.6	-		
Input Capacitance	C_{iss}	-	1535	-	pF	V_{GS}=0 V_{DS}=15V f=1.0MHz
Output Capacitance	C_{oss}	-	60	-		
Reverse Transfer Capacitance	C_{rss}	-	37	-		
Gate Resistance	R_g	-	2	-	Ω	f=1.0MHz
Source-Drain Diode						
Continuous Source Current [1]	I_S	-	-	15	A	
Pulsed Source Current [3],	I_{SM}	-	-	30	A	
Forward On Voltage [2]	V_{SD}	-	-	1.2	V	V_{GS}=0V , I_S=8A , T_J=25℃
Reverse Recovery Time	t_{rr}	-	37	-	nS	I_F=10A , dI/dt=100A/μs , T_J=25℃
Reverse Recovery Charge	Q_{rr}	-	27.3	-	nC	

Notes:
1. The data tested by surface mounted on a 1 inch^2 FR-4 board with 2OZ copper.
2. When mounted on minimum pad of copper.
3. The power dissipation is limited by 150℃ juncti on temperature.
4. The data tested by pulsed, pulse width ≦ 300us, duty cycle ≦ 2%

CHARACTERISTICS CURVE

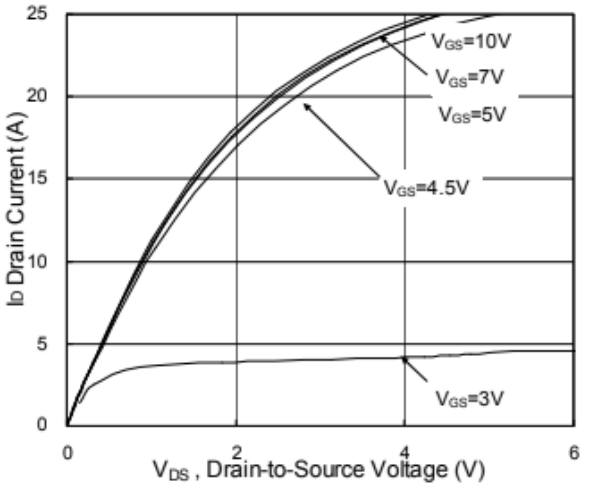


Fig.1 Typical Output Characteristics

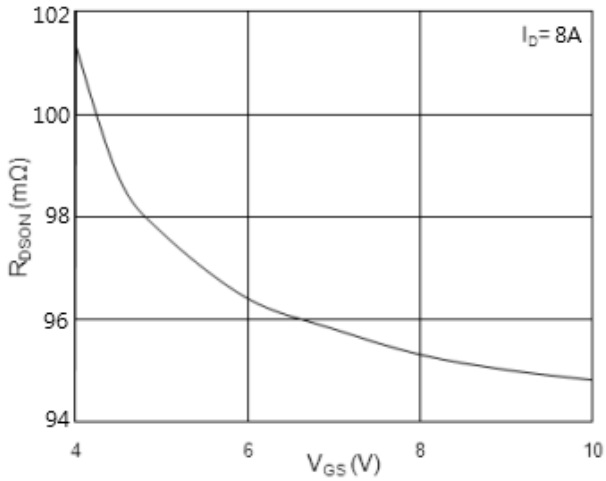


Fig.2 On-Resistance vs. Gate-Source

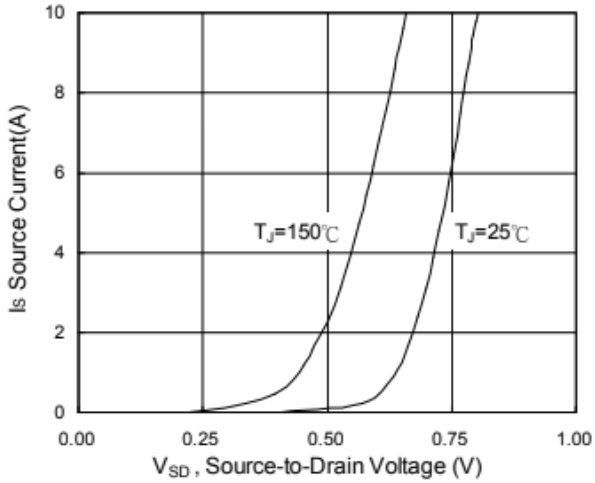


Fig.3 Forward Characteristics Of Reverse

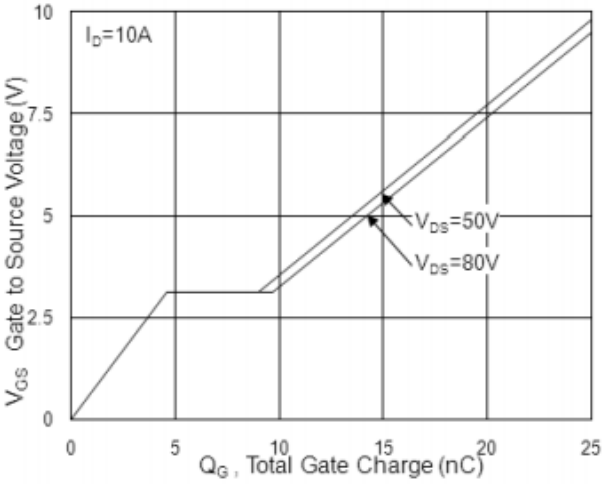


Fig.4 Gate-Charge Characteristics

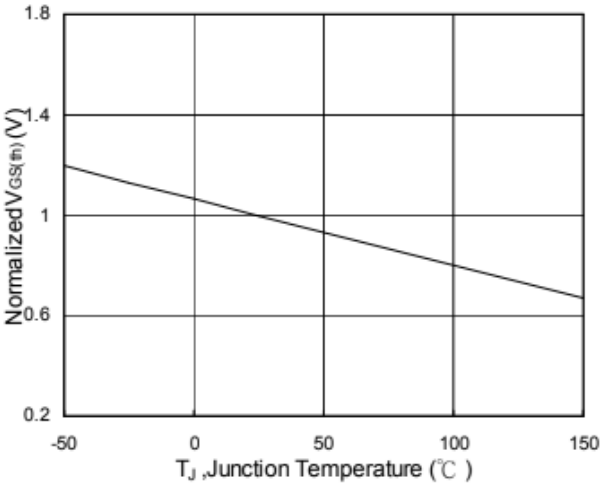


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

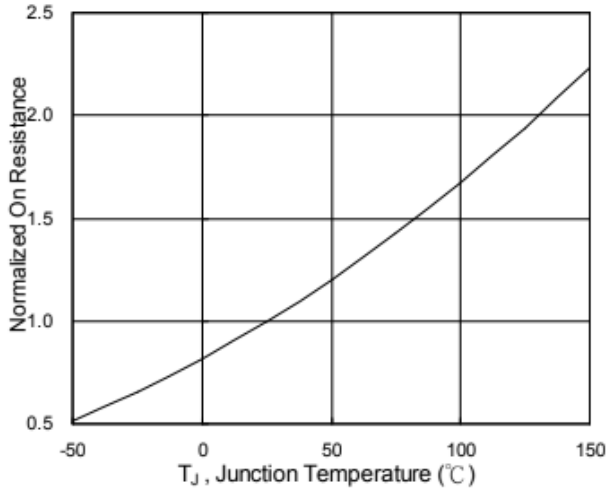


Fig.6 Normalized R_{DSON} vs. T_J

CHARACTERISTICS CURVE

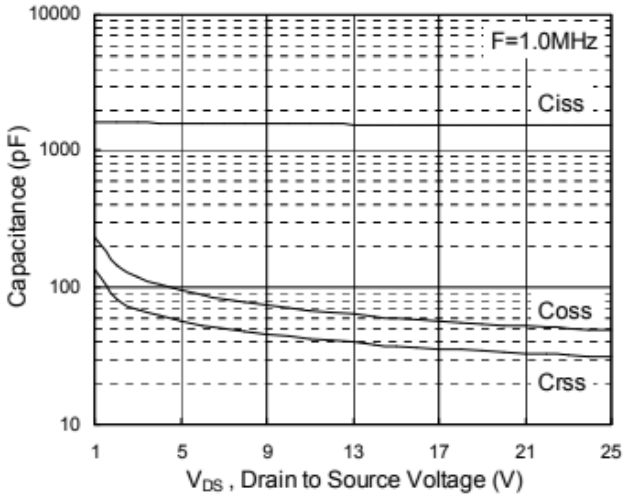


Fig.7 Capacitance

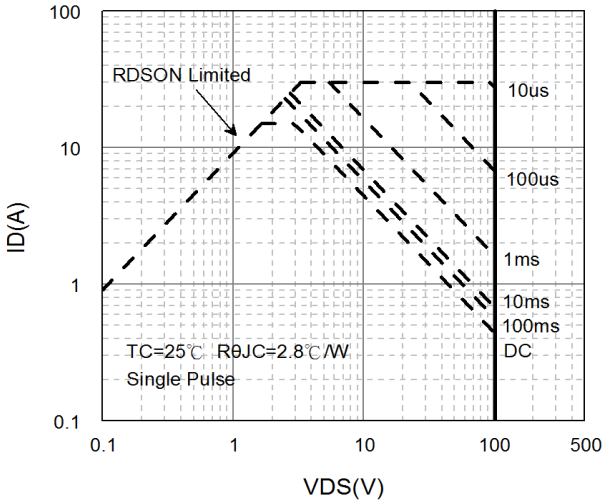


Fig.8 Safe Operating Area

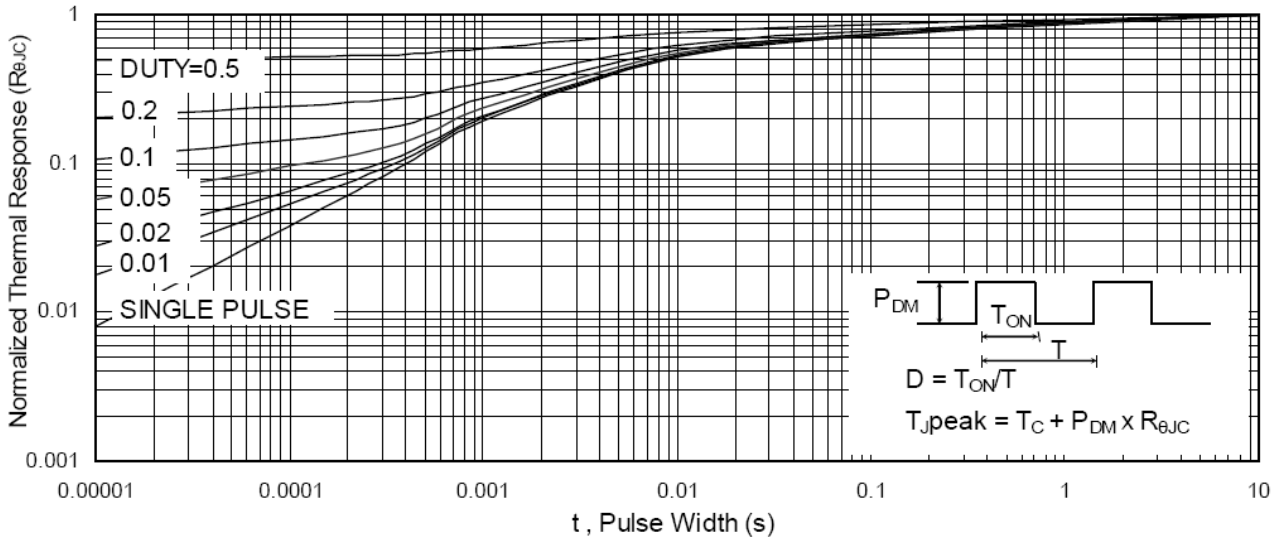


Fig.9 Normalized Maximum Transient Thermal Impedance

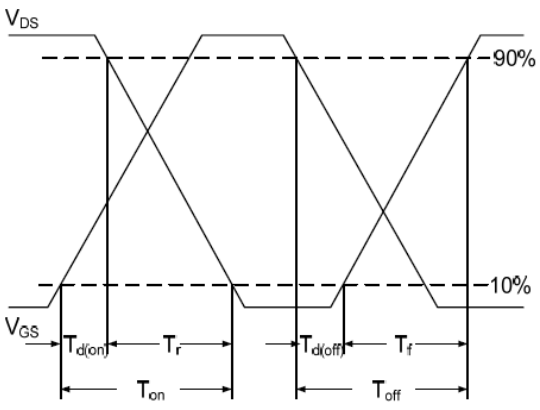


Fig.10 Switching Time Waveform

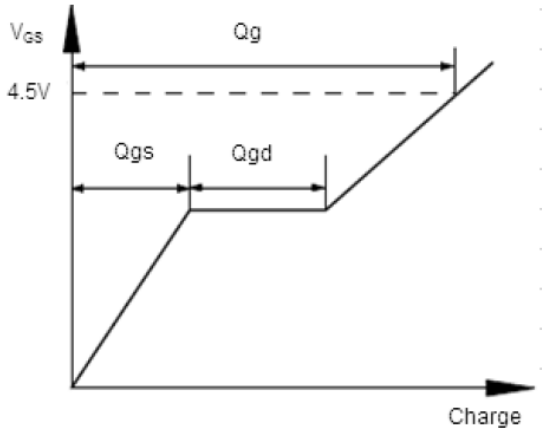


Fig.11 Gate Charge Waveform